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Kind regards,

Team Nexperia



PBSS5440D

40 V PNP low V_{CEsat} (BISS) transistor Rev. 02 — 14 December 2009

Product data sheet

Product profile

1.1 General description

PNP low V_{CEsat} Breakthrough in Small Signal (BISS) single bipolar PNP transistor in a SOT457 (SC-74) SMD plastic package.

NPN complement: PBSS4440D.

1.2 Features

- Ultra low collector-emitter saturation voltage V_{CEsat}
- 4 A continuous collector current capability I_C (DC)
- Up to 15 A peak current
- Very low collector-emitter saturation resistance
- High efficiency due to less heat generation

1.3 Applications

- Power management functions
- Charging circuits
- DC-to-DC conversion
- MOSFET gate driving
- Power switches (e.g. motors, fans)
- Thin Film Transistor (TFT) backlight inverter

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base		-	-	-40	V
I _C	collector current (DC)		[1]	-	-	-4	Α
I _{CM}	peak collector current	$t = 1$ ms or limited by $T_{j(max)}$		-	-	-15	Α
R _{CEsat}	collector-emitter saturation resistance	$I_C = -6 \text{ A};$ $I_B = -600 \text{ mA}$	[2]	-	55	75	mΩ

^[1] Device mounted on a ceramic Printed-Circuit Board (PCB), AL₂O₃, standard footprint.



^[2] Pulse test: $t_p \le 300~\mu s; \, \delta \le 0.02.$

2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Symbol
1	collector		
2	collector	<u> </u>	1, 2, 5, 6
3	base	0	3 —
4	emitter	1 12 13	
5	collector		4 sym030
6	collector		symese

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PBSS5440D	SC-74	plastic surface mounted package; 6 leads	SOT457

4. Marking

Table 4. Marking codes

Type number	Marking code
PBSS5440D	71

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	-40	V
V_{CEO}	collector-emitter voltage	open base	-	-40	V
V_{EBO}	emitter-base voltage	open collector	-	– 5	V
I _C	collector current (DC)		<u>[1]</u> -	-4	Α
I _{CM}	peak collector current	t = 1 ms or limited by $T_{j(max)}$	-	-15	Α
I _B	base current (DC)		-	-0.8	Α
I _{BM}	peak base current	$t_p \le 300~\mu s$	-	-2	Α
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	[2] -	360	mW
			[3] _	600	mW
			<u>[4]</u> _	750	mW
			<u>[1]</u> -	1.1	W
			[2][5]	2.5	W

Product data sheet

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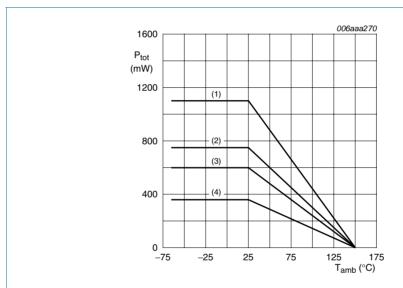
40 V PNP low V_{CEsat} (BISS) transistor

Table 5. Limiting values ... continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
T_{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	150	°C
T_{amb}	ambient temperature		-65	+150	°C

- Device mounted on a ceramic PCB, AL₂O₃, standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- Operated under pulsed conditions: Duty cycle $\delta \le 10\%$ and pulse width $t_p \le 10$ ms.



- (1) Ceramic PCB, AL₂O₃, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm²
- (3) FR4 PCB, mounting pad for collector 1 cm²
- (4) FR4 PCB, standard footprint

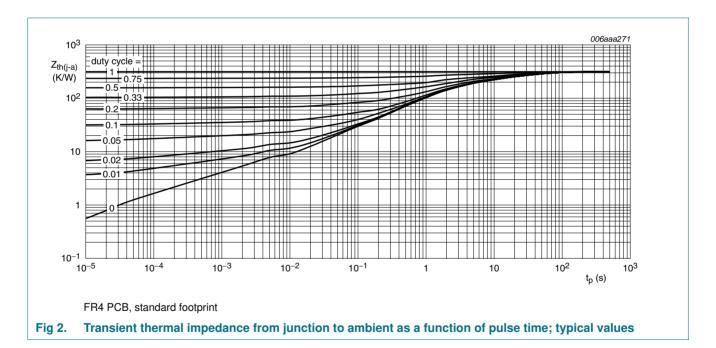
Power derating curves Fig 1.

6. Thermal characteristics

Table 6. Thermal characteristics

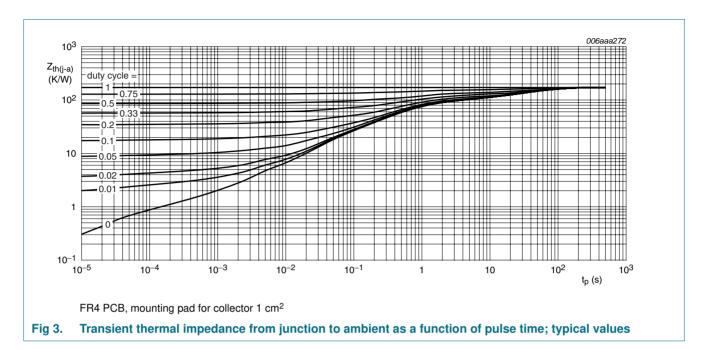
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from	in free air	<u>[1]</u> -	-	350	K/W
	junction to ambient		[2] -	[2]	208	K/W
		[3] -	[3] _	-	160	K/W
			<u>[4]</u> _	<u>[4]</u> 113	113	K/W
			[1][5] _	-	50	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	45	K/W

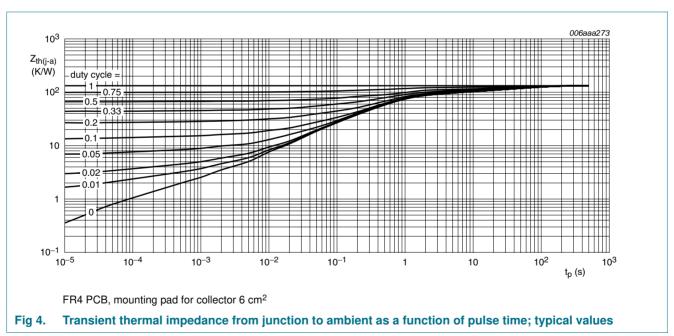
- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- [4] Device mounted on a ceramic PCB, AL₂O₃, standard footprint.
- [5] Operated under pulsed conditions: Duty cycle $\delta \le 10\%$ and pulse width $t_p \le 10$ ms.



NXP Semiconductors PBSS5440D

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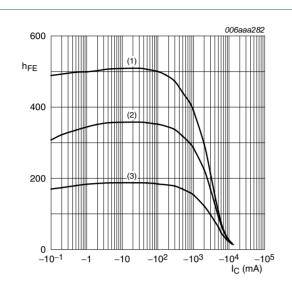
7. Characteristics

Table 7. Characteristics

T_{amb} = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = -30 \text{ V}; I_E = 0 \text{ A}$		-	-	-0.1	μΑ
	current	$V_{CB} = -30 \text{ V}; I_E = 0 \text{ A}; T_j = 150 ^{\circ}\text{C}$		-	-	-50	μΑ
Ices	collector-emitter cut-off current	$V_{CE} = -30 \text{ V}; V_{BE} = 0 \text{ V}$		-	-	-0.1	μΑ
ЕВО	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$		-	-	-0.1	μΑ
h _{FE}	DC current gain	$V_{CE} = -2 \text{ V}; I_{C} = -0.5 \text{ A}$		200	-	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}$	[1]	200	-	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}$	[1]	175	-	-	
		$V_{CE} = -2 \text{ V}; I_C = -4 \text{ A}$	[1]	80	-	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -6 \text{ A}$	[1]	30	-	-	
V _{CEsat}	collector-emitter	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$		-	-46	-60	mV
saturation voltage	saturation voltage	$I_C = -1 A$; $I_B = -50 \text{ mA}$		-	-70	-110	mV
		$I_C = -2 \text{ A}; I_B = -200 \text{ mA}$		-	-120	-180	mV
		$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	[1]	-	-220	-300	mV
		$I_C = -6 \text{ A}; I_B = -600 \text{ mA}$	[1]	-	-320	-450	mV
R _{CEsat}	collector-emitter saturation resistance	$I_C = -6 \text{ A}; I_B = -600 \text{ mA}$	[1]	-	55	75	mΩ
V _{BEsat}	base-emitter	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$		-	-0.8	-0.85	V
	saturation voltage	$I_C = -1 A$; $I_B = -50 \text{ mA}$		-	-0.84	-0.9	V
		$I_C = -1 A$; $I_B = -100 \text{ mA}$	[1]	-	-0.84	–1	V
		$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	<u>[1]</u>	-	-1.0	-1.1	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_C = -2 \text{ A}$		-	-0.8	-1.0	V
t _d	delay time	$V_{CC} = -10 \text{ V}; I_C = -2 \text{ A};$		-	12	-	ns
t _r	rise time	$I_{Bon} = -0.1 \text{ A}$; $I_{Boff} = 0.1 \text{ A}$		-	43	-	ns
t _{on}	turn-on time			-	55	-	ns
t _s	storage time			-	240	-	ns
.f	fall time			-	80	-	ns
off	turn-off time			-	320	-	ns
ŤΤ	transition frequency	$V_{CE} = -10 \text{ V}; I_{C} = -0.1 \text{ A};$ f = 100 MHz		-	110	-	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz		-	50	-	pF

^[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02.$



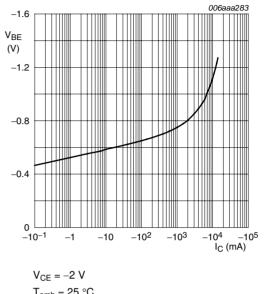
$$V_{CE} = -2 V$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

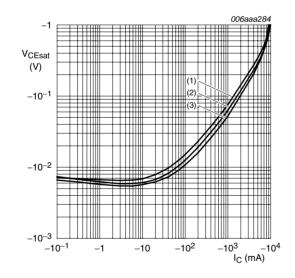
(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 5. DC current gain as a function of collector current; typical values



$$V_{CE} = -2 \text{ V}$$
 $T_{amb} = 25 \text{ °C}$

Fig 6. Base-emitter voltage as a function of collector current; typical values



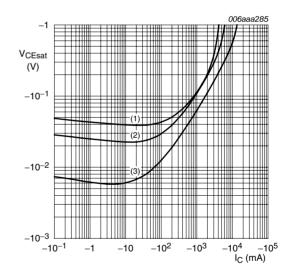


(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 7. Collector-emitter saturation voltage as a function of collector current; typical values



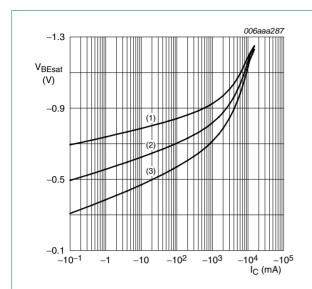
(1)
$$I_C/I_B = 100$$

(2)
$$I_C/I_B = 50$$

(3)
$$I_C/I_B = 10$$

Fig 8. Collector-emitter saturation voltage as a function of collector current; typical values

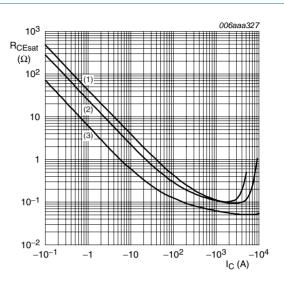
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$$I_C/I_B = 20$$

- (1) $T_{amb} = -55 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 9. Base-emitter saturation voltage as a function of collector current; typical values



- (1) $I_C/I_B = 100$
- (2) $I_C/I_B = 50$
- (3) $I_C/I_B = 10$

Fig 10. Collector-emitter saturation resistance as a function of collector current; typical values

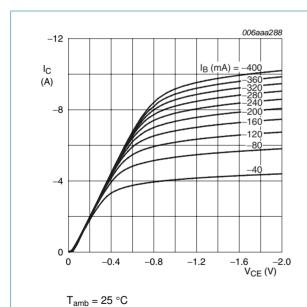
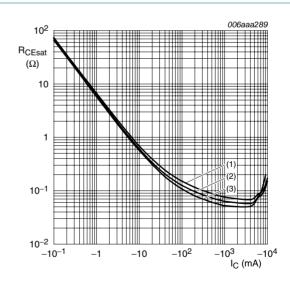


Fig 11. Collector current as a function of collector-emitter voltage; typical values



 $I_C/I_B = 20$

- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -55 \, ^{\circ}C$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

8. Test information

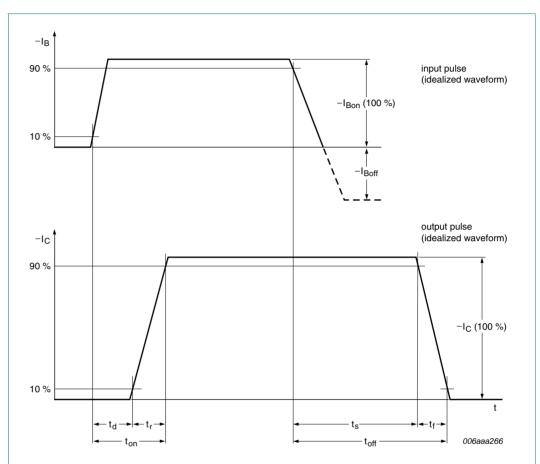
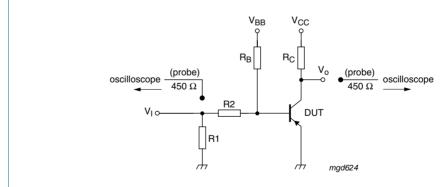


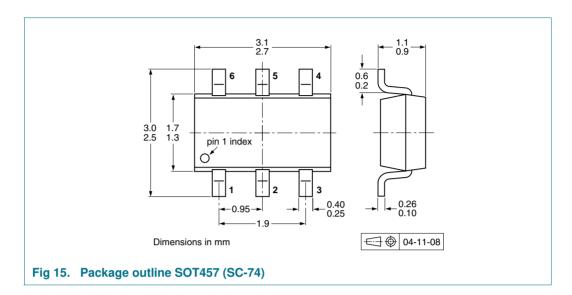
Fig 13. BISS transistor switching time definition



(1) $V_{CC} = -10 \text{ V}$; $I_{C} = -2 \text{ A}$; $I_{Bon} = -0.1 \text{ A}$; $I_{Boff} = 0.1 \text{ A}$

Fig 14. Test circuit for switching times

9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description		Packing quan		
				3000	5000	10000
PBSS5440D	SOT457	4 mm pitch, 8 mm tape and reel; T1	[2]	-115	-	-135
		4 mm pitch, 8 mm tape and reel; T2	[3]	-125	-	-165

- [1] For further information and the availability of packing methods, see Section 13.
- [2] T1: normal taping
- [3] T2: reverse taping

PBSS5440D

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11. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
PBSS5440D_2	20091214	Product data sheet	-	PBSS5440D_1		
Modifications:	including nev content.	nsient thermal impedance	claimers. No changes w	ne NXP Semiconductors, vere made to the technical nt as a function of pulse time;		
	 Figure 3 "Transient thermal impedance from junction to ambient as a function of pulse time; typical values": updated 					
	 Figure 4 "Transient thermal impedance from junction to ambient as a function of puls typical values": updated Figure 6 "Base-emitter voltage as a function of collector current; typical values": upd 					
	 Figure 11 "Coupdated 	ollector current as a function	on of collector-emitter v	voltage; typical values":		
PBSS5440D_1	20050427	Product data sheet	-	-		

PBSS5440D

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12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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